Optoelectronics and optoelectronic devices

# Numerical simulation of perovskite solar cell with different material as electron transport layer using SCAPS-1D software

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**Abstract.** Perovskite solar cells have become a hot topic in the solar energy device area due to high efficiency and low cost photovoltaic technology. However, their function is limited by expensive hole transport material (HTM) and high temperature process electron transport material (ETM) layer is common device structure. Numerical simulation is a crucial technique in deeply understanding the operational mechanisms of solar cells and structure optimization for different devices. In this paper, device modelling for different perovskite solar cell has been performed for different ETM layer, namely: TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM (phenyl-C61-butyric acid methyl ester), CdZnS, C<sub>60</sub>, IGZO (indium gallium zinc oxide), WS<sub>2</sub> and CdS and effect of band gap upon the power conversion efficiency of device as well as effect of absorber thickness have been examined. The SCAPS 1D (Solar Cell Capacitance Simulator) has been a tool used for numerical simulation of these devices.

**Keywords:** perovskite, solar cell, simulation, SCAPS-1D, power conversion efficiency, hole transport material, electron transport material.

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# 1. Introduction

Perovskite solar cells (PSCs) represent an emerging photovoltaic technology due to their efficiency increased substantially from 3.8% efficiency recorded in 2009 [1] to 22.7% in 2017 [2] and about 27.3% in 2018 [3], which is still rising with pace. Fig. 1 shows the planer structure of perovskite solar cells. It consists of an electron transporting layer (ETL), absorbing layer and hole transporting layer (HTL). The absorbing layer constitutes of perovskite material and as inorganic HTMs include NiO, Cul, Cu<sub>2</sub>O and CuSCN, whereas organic HTLs are spiro-MeOTAD, P3HT, PTAA, PEDOT:PSS etc. and various ETLs are TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM (phenyl-C61butyric acid methyl ester), CdZnS, C<sub>60</sub>, IGZO (indium gallium zinc oxide), WS<sub>2</sub>, CdS etc. Solar cell performance depends on its layers. G.A. Casas [4] proposed effects of using five different materials as HTL in perovskite solar cells have been analyzed and find out that the efficiency close to 28% has been obtained for Cu<sub>2</sub>O/perovskite/TiO<sub>2</sub> solar cell.

In this work, different materials were studied for possible ETL like TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM, CdZnS, C<sub>60</sub> (buckminsterfullerene), IGZO (indium gallium zinc oxide), WS<sub>2</sub> and CdS. The studies have been carried out by means of computer simulation. These materials have different mobilities ( $\mu_n$  and  $\mu_p$ ), electron affinities ( $\chi_e$ ), band gap energies ( $E_g$ ) and defect densities ( $N_t$ ) due to these parameters alignments between the valence bands of both ETL and perovskite layer are different. Then performance parameters like open circuit voltage ( $V_{oc}$ ), short circuit current ( $I_{sc}$ ), fill factor (FF) and power conversion efficiency (PCE) change.

#### 2. Materials and methods

#### 2.1. Device structure and modelling

The perovskite (CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub>) solar cell simulated in this work is shown in Fig. 1. It is one dimensional device with *n*-*i*-*p* planner structure. The *n*-region is ETL, the region is perovskite layer and *p*-region is HTL. When the cell is subjected to light, excitons (bound state of electron



**Fig. 1.** General schematic structure for a perovskite solar cell, the sun is the illumination source [5]. ETL - electron transporting layer, HTL - hole transporting layer.

and hole) are mainly created in perovskite *i*-region. According to their diffusion length, they can reach the n(p)-region. At the n/i interface, the exciton is dissociated, and electron moves toward the *n*-layer, similarly at the input interface, exciton is dissociated and hole moves to the *p*-layer while remaining electron migrates to the *n*-layer. Dissociation of excitons as well as migration of electrons and holes are favoured by electrical field between the *n*- and *p*-layers.

Numerical simulation of planer perovskite solar cell were performed with one dimensional code SCAPS-1D (solar cells capacitance simulator), which is used to determine current density *vs* voltage characteristics, energy band diagram, quantum efficiencies/spectral response, functional parameters (open circuit voltage, total current density, fill factor, and power conversion efficiency), total recombination currents, AC quantities and electron/hole densities. This numerical program solves numerically the three basic semiconductor equations: the Poisson equation and continuity equations for holes and electrons (Raoui *et al.*, 2019 [6]; Jamil *et al.*, 2020 [7]).

The Poisson (1) and continuity equations for holes (2) and electrons (3) are as follows:

$$\frac{d}{dx}\left(\varepsilon(x)\frac{d\psi}{dx}\right) = q\left[p(x) - n(x) + N_D^+(x) - N_A^-(x) + p_t(x) - n_t(x)\right], \quad (1)$$

$$\frac{1}{J}\frac{\partial J_p}{\partial x} + R_p(x) - G(x) = 0, \qquad (2)$$

$$-\frac{1}{J}\frac{\partial J_n}{\partial x} + R_n(x) - G(x) = 0.$$
(3)

Here,  $\varepsilon$  is the permittivity, q – charge of electron,  $\psi$  – electrostatic potential and n – electrons' concentration, p – free hole concentration,  $n_t$  – trapped electron,

Layer ETL Symbol TiO<sub>2</sub> ZnO PCBM CdZnS IGZO Parameters SnO<sub>2</sub>  $WS_2$ C<sub>60</sub> CdS (Unit) Thickness  $W(\mu m)$ 0.1 0.1 0.1 0.1 0.1 0.1 0.1 0.1 0.1 3.3 2 2.4 3.2 3.5 3.2 1.8 1.7 3.05 Band gap  $E_{\varphi}(eV)$ Electron affinity χ(eV) 3.9 4.1 3.9 4 4.2 3.95 3.9 4.5 4.16 Relative dielec-9 9 3.9 34.8 9.12 13.6 4.2 10 10 ε, tric permittivity Effective density of states (DOS) in the  $1 \cdot 10^{19}$  $4 \cdot 10^{18}$  $2.5 \cdot 10^{21}$  $2.4 \cdot 10^{18}$  $1.5 \cdot 10^{18}$  $2.2 \cdot 10^{18}$  $8 \cdot 10^{19}$  $5 \cdot 10^{18}$  $2.2 \cdot 10^{18}$  $N_c \,({\rm cm}^{-3})$ conduction band Effective density of states (DOS)  $1 \cdot 10^{19}$  $1 \cdot 10^{19}$  $1.8 \cdot 10^{19}$  $1.9 \cdot 10^{19}$  $8 \cdot 10^{19}$  $5 \cdot 10^{18}$  $1.9 \cdot 10^{19}$  $N_{v} \,({\rm cm}^{-3})$  $2.5 \cdot 10^{21}$  $1.8 \cdot 10^{19}$ in the valence band Mobility of  $\mu_e$  $8 \cdot 10^{-2}$ 15 20 100 0.2 20 250 100 350  $(cm^2 \cdot V^{-1} \cdot s^{-1})$ electrons  $\mu_h$  $3.5 \cdot 10^{-3}$ 10 0.2 10 40 100 0.1 25 Mobility of holes 25  $(cm^2 \cdot V^{-1} \cdot s^{-1})$ 0 0 0 0 0 0 0 0 0 Acceptor density  $N_A (\mathrm{cm}^{-3})$  $1 \cdot 10^{16}$  $1 \cdot 10^{16}$ Donor density  $N_D (\mathrm{cm}^{-3})$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$ Defect density  $n_t \,({\rm cm}^{-3})$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$  $1 \cdot 10^{14}$ 

**Table 1.** Physical parameters for various ET layers [8].

Table 2. I	Physical	parameters f	for absorbe	er [8]	and HT	layer [3].
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Layer	Perovskite [7]	HTL [3]	
Parameters	Symbol (Unit)	CH <sub>3</sub> NH <sub>3</sub> PbI <sub>3</sub>	Cu <sub>2</sub> O
Thickness	W (µm)	0.6	0.4
Band gap	$E_g$ (eV)	1.55	2.17
Electron affinity	χ (eV)	3.9	3.2
Relative dielectric permittivity	ε <sub>r</sub>	32	6.6
Effective density of states (DOS) in the conduction band	$N_c (\mathrm{cm}^{-3})$	$2.8 \cdot 10^{18}$	$2.50 \cdot 10^{20}$
Effective density of states (DOS) in the valence band	$N_{v} (\mathrm{cm}^{-3})$	3.9·10 <sup>18</sup>	$2.50 \cdot 10^{20}$
Mobility of electrons	$\mu_e (\mathrm{cm}^2 \cdot \mathrm{V}^{-1} \cdot \mathrm{s}^{-1})$	11.8	80
Mobility of holes	$\mu_h(\mathrm{cm}^2 \cdot \mathrm{V}^{-1} \cdot \mathrm{s}^{-1})$	11.8	80
Acceptor density	$N_A (\mathrm{cm}^{-3})$	$1 \cdot 10^{13}$	3.1018
Donor density	$N_D (\mathrm{cm}^{-3})$	$1 \cdot 10^{13}$	0
Defect density	$n_t (\mathrm{cm}^{-3})$	$3 \cdot 10^{14}$	$1 \cdot 10^{15}$

Here,  $N_c$  and  $N_v$  are the effective density of states (DOS) in the conduction and valence bands, respectively,  $\mu_h$  and  $\mu_e$  – hole and electron mobilities, respectively,  $\varepsilon_r$  is the relative permittivity, and  $N_A$  and  $N_D$  are acceptor and donor impurity concentrations, respectively.

Table 3. Performance of solar ce	ll obtained from simulations	for each ETL material	(according to ref. [8]).

	$V_{oc}$ (V)		$J_{sc}$ (mA/cm <sup>2</sup> )		FF		PCE (%)	
Device structure	[8]	This work	[8]	This work	[8]	This work	[8]	This work
ZnO/MAPbI <sub>3</sub> /Spiro-MeOTAD	1.01	1.07	26.79	24.38	82.89	82.64	22.37	21.73
SnO <sub>2</sub> /MAPbI <sub>3</sub> /Spiro-MeOTAD	1.00	1.05	26.66	24.41	82.59	82.58	22.13	21.35
TiO <sub>2</sub> /MAPbI <sub>3</sub> /Spiro-MeOTAD	1.00	1.05	26.76	24.39	82.66	82.99	22.24	21.37
CdZnS/MAPbI <sub>3</sub> /Spiro-MeOTAD	0.99	1.08	26.78	24.37	83.19	78.77	22.25	20.08
IGZO/MAPbI <sub>3</sub> /Spiro-MeOTAD	0.96	1.08	26.36	24.33	82.35	79.02	20.83	20.82
WS <sub>2</sub> /MAPbI <sub>3</sub> /Spiro-MeOTAD	1.00	1.05	26.40	24.50	83.76	81.55	22.11	21.07
PCBM/MAPbI <sub>3</sub> /Spiro-MeOTAD	0.94	1.06	26.38	24.05	82.48	77.48	20.34	19.94
C <sub>60</sub> /MAPbI <sub>3</sub> /Spiro-MeOTAD	0.92	1.05	26.25	23.88	69.99	73.03	16.95	16.73
CdS/MAPbI <sub>3</sub> /Spiro-MeOTAD	0.71	0.78	26.34	24.28	77.91	75.82	14.64	14.03

Table 4. Performance of solar cell obtained from simulations for each ETL material (proposed MAPbI<sub>3</sub> based *n-i-p* structures).

Device structure	$V_{oc}$ , V	$J_{sc}$ , mA/cm <sup>2</sup>	FF	PCE, %
ZnO/MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.11	24.49	84.85	23.21
SnO <sub>2</sub> /MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.10	24.49	83.18	22.48
TiO <sub>2</sub> /MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.10	24.49	83.56	22.54
CdZnS/MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.12	24.49	82.86	22.74
IGZO/MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.12	24.44	82.88	22.69
WS <sub>2</sub> /MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.09	24.57	81.46	22.05
PCBM/MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.10	24.13	78.14	20.85
C <sub>60</sub> /MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.09	23.80	72.16	18.83
CdS/MAPbI <sub>3</sub> /Cu <sub>2</sub> O	1.12	24.42	58.94	16.19



Fig. 2. Effect of different ETL layer on current density vs voltage characteristics. (Color online.)

 $p_t$  – trapped hole,  $N_D^+$  – ionized donor like doping and  $N_A^-$  – ionized acceptor like doping concentrations,  $R_n(x)$ ,  $R_p(x)$  are electrons and holes recombination rates, G(x) is the generation rate,  $J_n$  and  $J_p$  are the electron and hole current densities, respectively.

The device modelling in this work was performed by SCAPS-1D software. In this approach, perovskite solar cells are simulated with three input layers, where *n*type TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM, CdZnS, C<sub>60</sub>, IGZO, WS<sub>2</sub> and CdS are used separately in order to compare their performance as ETL, perovskite is used as an absorbing layer, and p-type Cu<sub>2</sub>O is used as HTL. Here, carbon is used as the back contact, and fluorine doped tin oxide (FTO) – as the front contact. For simulation under illumination condition standard AM1.5G spectrum  $(1000 \text{ W/m}^2, T = 300 \text{ K})$  was used.

For simulation, physical parameters used for different ETL layers are given in Table 1, while those for the absorbing (CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub>) and HT layers are given in Table 2.

#### 3. Results and discussion

# 3.1. Comparisons analysis of different ETLs and their performance

According to Khattak et al. [7], the effect of band gap width and electron affinity of ETL on solar cell performance having the device structure ETL/MAPbI<sub>3</sub>/Spiro-MeOTAD for different ETLs having the same donor doping concentration and thickness given in Table 3 from these results indicates that each ETL has its own effect on parameters, namely: short circuit current, open circuit voltage, fill factor and conversion efficiency. This is caused by different band structures of ETL, which can be offered when forming the junction with the absorbing layer.

The result of PCE calculated for various ETL materials and keeping fixed the HT and perovskite layers are summarized in Table 4.



Fig. 3. Bands alignment between ETL, perovskite and HTL [9].

In this paper, Cu<sub>2</sub>O is used as HTL material, because according to Casas et al. [4] this material gives the maximum efficiency. In all these ETLs have the same donor doping concentration  $1 \cdot 10^{16} \text{ cm}^{-3}$ , and the thickness value is 0.1 µm as optimized by Khattak et al. [8]. From this result, it is observed that each ETL has its own effect on different performance parameters, namely: short circuit current  $(J_{sc})$ , open circuit voltage  $(V_{oc})$ , fill and PCE of ETL (n-type)/perovskite factor (CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub>)/HTL (Cu<sub>2</sub>O, *p*-type) device structure. The effect of different ETLs on performance parameters is described in Table 4, and the current density vs voltage characteristics is demonstrated in Fig. 2. According to these results, we find out that as ETL ZnO material structure gives maximum PCE (23.21%). This happens because of different band structures that ETL can offer when forming a junction with the absorbing layer. The type of band structure that ETL can form with the absorbing layer is shown in Fig. 3.

The best efficiency is noticed for ZnO,  $SnO_2$ ,  $TiO_2$ , CdZnS, IGZO and WS<sub>2</sub> above 20%. This is caused by adequate bands' alignment between the conduction band and LUMO (Lowest Unoccupied Molecular Orbital) of perovskite according to Figs 3 and 4, and also consider that some of their input parameters seem to be similar, but it is also influenced by the mobility of electrons and defect density.

#### 3.2. Effect of variation in the absorber thickness

The effect of absorber thickness from 0.2 to 4.0 µm is shown in Fig. 5 for the required parameters: short circuit current  $(J_{sc})$ , open circuit voltage  $(V_{oc})$ , fill factor (FF) and PCE. Here,  $V_{oc}$  decreases from 1.16 down to 1.02 V, FF changes from 86.00 to 73.45%,  $J_{sc}$  increases up to 1.5-µm thickness, and after that the constant value is obtained and PCE (23.21%) reaches its maximum at the 0.6-µm absorber thickness. So, it is conformed from this data of 0.6-µm thickness that the absorbing layer has better performance and higher PCE (23.21%) with FF (84.85%) and  $J_{sc}$  (24.49 mA/cm<sup>2</sup>) parameters' values.



Fig. 4. Band diagram of ETL with the absorbing layer.

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Fig. 5. Variation in absorber thickness with respect to performance parameters, keeping fixed ETL and HTL thicknesses.

#### 4. Conclusions

In this work, detailed analysis has been performed for modelling the n-i-p structure for CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> based perovskite solar cells. SCAPS-1D software was used for this modelling and nine different materials (TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM, CdZnS, C<sub>60</sub>, IGZO, WS<sub>2</sub> and CdS) as electron transporting layer and Cu<sub>2</sub>O as hole transport layer. The results obtained in this work show that most crucial effect on PCE is alignment between the maximum of valence band of ETL and perovskite materials which is directly related to band gap energy and electron affinity of each material. The band alignment is not only parameters that affect the better efficiency of cell but also mobility, which plays a crucial role between materials that have almost similar band alignment properties. The effect of variation in thickness of absorber on power conversion efficiency has been studied and optimized thickness found to be  $0.6 \,\mu m$  with better PCE close to 23.21%.

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Чисельне моделювання сонячного елемента на основі перовскіту з різним матеріалом шару з електронною провідністю за допомогою програмного забезпечення SCAPS-1D

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Анотація. Сонячні елементи на основі перовскіту стали гарячою темою в області приладів сонячної енергетики завдяки високій ефективності та недорогій технології фотовольтаїки. Однак їх застосування обмежено високою вартістю матеріалу, що забезпечує діркову провідність, у той же час високотемпературний шар матеріалу з електронною провідністю є загальною структурою таких пристроїв. Чисельне моделювання є найважливішим методом для глибокого розуміння механізмів роботи сонячних елементів та оптимізації структури для різних пристроїв. У цій роботі проведено моделювання пристрою для різних перовскітних сонячних елементів для різних шарів із матеріалу з дірковою провідністю, а саме: TiO<sub>2</sub>, ZnO, SnO<sub>2</sub>, PCBM, CdZnS, C60, IGZO, WS<sub>2</sub> та CdS, та досліджено вплив ширини забороненої зони на ефективність перетворення енергії пристрою, а також вплив товщини поглинаючого шару. SCAPS 1D (імітатор ємності сонячних елементів) є інструментом, що використовується для чисельного моделювання цього пристрою.

**Ключові слова:** перовскіт, сонячний елемент, моделювання, SCAPS-1D, ефективність перетворення енергії, матеріал з електронною провідністю, матеріал з дірковою провідністю.